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Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
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Example: optical <and> (fiber <or> fibre) <in> ti
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(calculate <or> determine)
 <and> diffractive efficiencies
 <and> memory

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	Search Text
1	((diffraction adj efficienc\$4) with lens
2	((diffraction adj efficienc\$4) with lens) and (memory or processor)
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4	((calculat\$3 or determin\$5) with (diffraction adj efficienc\$4)) with lens) and (weigh\$3)
5	((calculat\$3 or determin\$5) with (diffraction adj efficienc\$4)) with lens) and (memory or processor)
6	((measur\$4) with (diffraction adj efficienc\$4)) with lens
7	design\$3 with (diffraction adj lens)
8	(356/124).CCLS.
9	(359/558-570).CCLS.
10	((diffraction adj efficienc\$4) with lens) and (((356/124).CCLS.) or ((359/558-570).CCLS.))